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Time resolution of an irradiated 3D silicon pixel detector

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We report on the measurements of time resolution for double-sided 3D pixel sensors with a single cell of 50 μ m × 50 μ m and thickness of 285 μ m, fabricated at IMB-CNM and irradiated with reactor neutrons to 8e14 MeV n_{eq}/cm^2 and then to 2.3e15 MeV n_{eq}/cm^2 . Measurements were conducted using a radioactive source at a temperature of -20 and 20 \textdegree C in a bias voltage range of 50-300 V. The reference time was provided by an LGAD detector produced by Hamamatsu.

In order to reduce the effect on jitter a detector has been produced and tested with the same technology but with a thickness of 235 μm . The results obtained are compared to measurements conducted prior to irradiation.

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